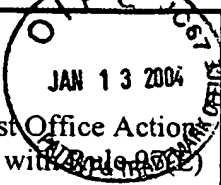
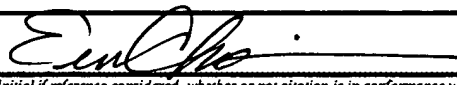
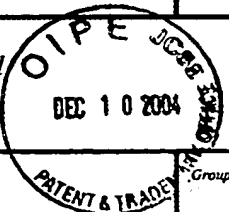
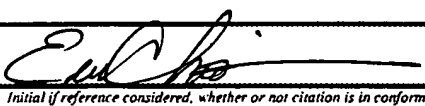


FORM PTO-1449		US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Atty. Docket No. 85975SHS Customer No. 01333		Serial No. 10/668,421	
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U.S. PATENT DOCUMENTS									
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
FOREIGN PATENT DOCUMENTS									
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO			
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)									
efc "Resistivity Measurements on Buried Conductive Layers" by Robert A. Elder. EOS/ESD Symposium Proceedings, September 1990. pp. 251-254.									
EXAMINER 				DATE CONSIDERED 7/28/05					
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>									

FOR: PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Any. Docket No. 85975SHS Customer No. 01333		Serial No. 10/668,421		
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee LIST OF ART CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		Applicant: Marcus S. Bermel, et al		<div style="text-align: center;">  </div>		
		Filing Date 25 February 2003				
U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>ed/c</i>	4,419,663	12-06-1983	Tadao Kohasi	340	783	03-07-1980
<i>ed/c</i>	5,469,278	11-21-1995	Hiroshi Takahara et al.	359	51	11-18-1994
FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER 			DATE CONSIDERED 7/28/05			
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